

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10576695	NAKANO ET AL.
	Examiner	Art Unit
	MARCOS BATISTA	4134

SEARCHED

Class	Subclass	Date	Examiner
455	346	2/20/2008	mb
455	574	2/20/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Steve D'Agosta	2/21/2008	mb
Consulted w/ lab TA Yogesh Aggarwal	2/21/2008	mb
Consulted with Lun-Yi Lao	2/21/2008	mb
East Search	2/20/2008	mb
Inventor's Name Search	2/20/2008	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner